10-FY07NMB150S5-LE75F08

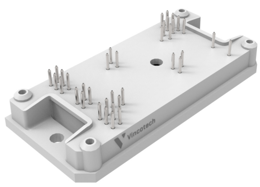
datasheet

*flow*MNPC 1	650 V / 150 A

Features

- Optimal for 120V grid
- Four quadrant operation
- Fast switching IGBTs
- Pin compatible to L36x family

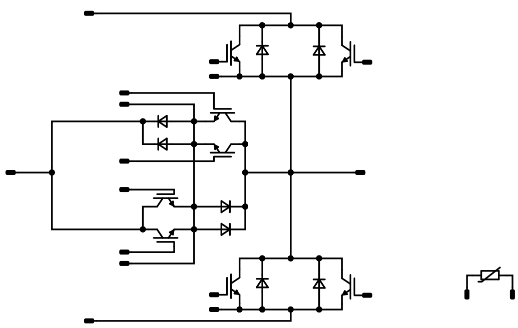
flow 1 12 mm housing



Target applications

- Solar Inverters
- UPS

Schematic



Types

- 10-FY07NMB150S5-LE75F08

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value	Unit
Buck Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$	T_s = 80 °C	105	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		450	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	145	W
Gate-emitter voltage	V_{GES}			±20	V
Maximum junction temperature	T_{jmax}			175	°C
Buck Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	101	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		300	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	127	W
Maximum junction temperature	T_{jmax}			175	°C
Boost Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$	T_s = 80 °C	105	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		450	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	145	W
Gate-emitter voltage	V_{GES}			±20	V
Maximum junction temperature	T_{jmax}			175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value	Unit
Boost Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	101	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		300	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	127	W
Maximum junction temperature	T_{jmax}			175	°C
Module Properties					
Thermal Properties					
Storage temperature	T_{stg}			-40…+125	°C
Operation temperature under switching condition	T_{jop}			-40…+(T_{jmax} - 25)	°C
Isolation Properties					
Isolation voltage	V_{isol}	DC Test Voltage*	t_p = 2 s	6000	V
Isolation voltage	V_{isol}	AC Voltage	t_p = 1 min	2500	V
Creepage distance				>12,7	mm
Clearance				8,07	mm
Comparative Tracking Index	CTI			≥ 200	

*100 % tested in production

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	Unit
Buck Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}$			0,0015	25	3,2	4	4,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		150	25 125 150		1,43 1,52 1,55	1,75(1)	V
Collector-emitter cut-off current	I_{CES}		0	650		25			100	µA
Gate-emitter leakage current	I_{GES}		20	0		25			200	nA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	f = 1 Mhz	0	25		25		9000		pF
Output capacitance	C_{oes}							260		pF
Reverse transfer capacitance	C_{res}							34		pF
Gate charge	Q_g	V_{CC} = 520 V	15		150	25		328		nC
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						0,65		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 8 Ω R_{goff} = 8 Ω	±15	150	150	25 125 150		160 158 158		ns
Rise time	t_r					25 125 150		61 61 63		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		132 137 145		ns
Fall time	t_f					25 125 150		28,77 30,18 37,32		ns
Turn-on energy (per pulse)	E_{on}	Q_{rFWD}=3,77 µC Q_{rFWD}=7,66 µC Q_{rFWD}=9,02 µC				25 125 150		0,741 0,767 0,948		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,898 1,37 1,51		mWs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	Unit
Buck Diode										
Static										
Forward voltage	V_F				150	25 125 150		1,53 1,49 1,47	1,92(1)	V
Reverse leakage current	I_R	V_r = 650 V				25			7,6	µA
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						0,75		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt=1547 A/µs di/dt=2604 A/µs di/dt=2356 A/µs	±15	150	150	25 125 150		47,43 77,84 82,86		A
Reverse recovery time	t_{rr}					25 125 150		132,34 181,58 210,39		ns
Recovered charge	Q_r					25 125 150		3,77 7,66 9,02		µC
Reverse recovered energy	E_{rec}					25 125 150		0,39 0,833 0,992		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		438,99 710,33 724,44		A/µs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Values Min	Typ	Max	Unit
Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}$			0,0015	25	3,2	4	4,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		150	25 125 150		1,43 1,52 1,55	1,75(1)	V
Collector-emitter cut-off current	I_{CES}		0	650		25			100	µA
Gate-emitter leakage current	I_{GES}		20	0		25			200	nA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	f = 1 Mhz	0	25		25		9000		pF
Output capacitance	C_{oes}							260		pF
Reverse transfer capacitance	C_{res}							34		pF
Gate charge	Q_g	V_{CC} = 520 V	15		150	25		328		nC
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						0,65		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 8 Ω R_{goff} = 8 Ω	±15	150	150	25 125 150		144 148 148		ns
Rise time	t_r					25 125 150		56 60 62		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		117 128 131		ns
Fall time	t_f					25 125 150		23,5 33,51 32,23		ns
Turn-on energy (per pulse)	E_{on}	Q_{rFWD}=3,72 µC Q_{rFWD}=7,61 µC Q_{rFWD}=8,53 µC				25 125 150		0,688 0,935 0,907		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,872 1,26 1,31		mWs

Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Boost Diode										
Static										
Forward voltage	V_F				150	25 125 150		1,53 1,49 1,47	1,92(1)	V
Reverse leakage current	I_R	V_r = 650 V				25			7,6	µA
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						0,75		K/W
Dynamic										
Peak recovery current	I_{RRM}	d*i*/d*t*=2492 A/µs d*i*/d*t*=2231 A/µs d*i*/d*t*=2194 A/µs	±15	150	150	25 125 150		54,38 79,9 81,98		A
Reverse recovery time	t_{rr}					25 125 150		136,65 196,69 229,18		ns
Recovered charge	Q_r					25 125 150		3,72 7,61 8,53		µC
Reverse recovered energy	E_{rec}					25 125 150		0,368 0,753 0,819		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		851,42 847,21 893		A/µs

Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Thermistor										
Static										
Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	R_{100} = 1484 Ω				100	-5		5	%
Power dissipation	P							5		mW
Power dissipation constant	d					25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %						3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %						4000		K
Vincotech Thermistor Reference									I	

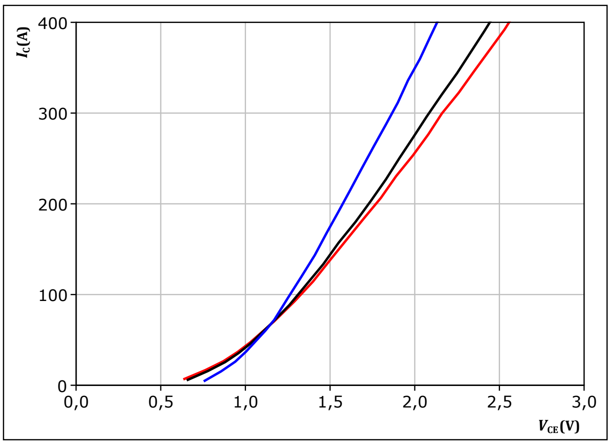
(1) Value at chip level
(2) Only valid with pre-applied Vincotech thermal interface material.

Buck Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

I_C = f(V_{CE})



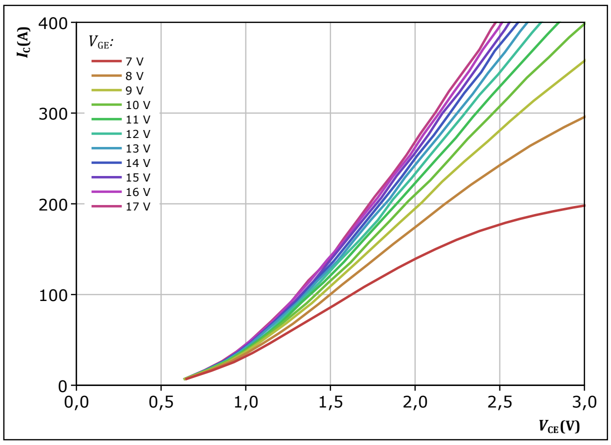
t_p =	250	μs
V_{GE} =	15	V

T_j: 25 °C, 125 °C, 150 °C

figure 2. **IGBT**

Typical output characteristics

I_C = f(V_{CE})



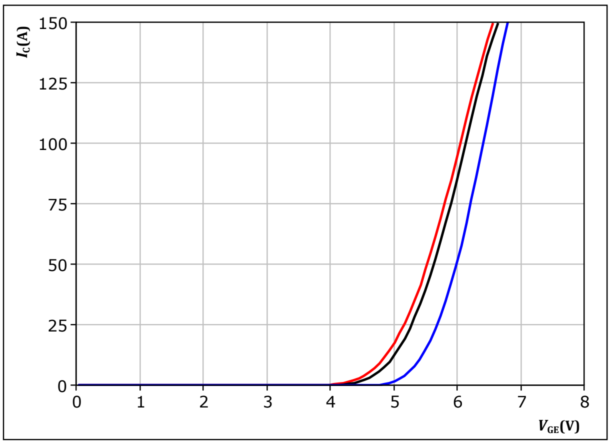
t_p =	250	μs
T_j =	150	°C

V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. **IGBT**

Typical transfer characteristics

I_C = f(V_{GE})



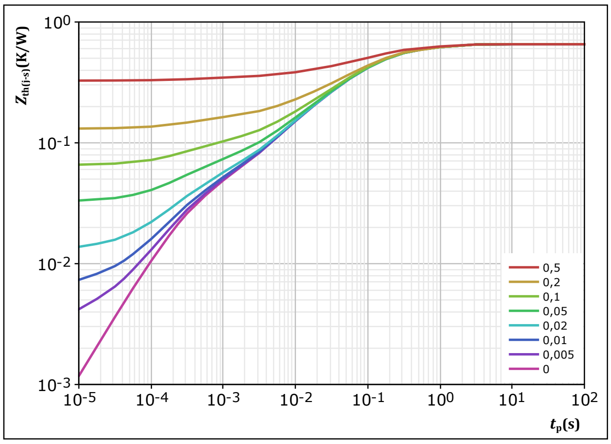
t_p =	250	μs
V_{CE} =	10	V

T_j: 25 °C, 125 °C, 150 °C

figure 4. **IGBT**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)}$ = f(t_p)



D =	t_p / T	
$R_{th(j-s)}$ =	0,654	K/W

IGBT thermal model values

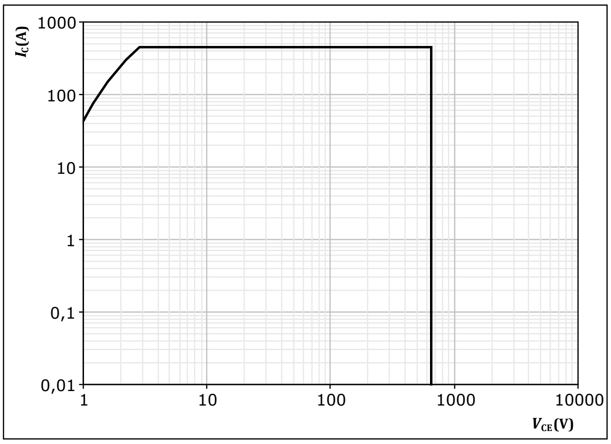
R (K/W)	τ (s)
1,13E-01	8,46E-01
2,91E-01	1,23E-01
1,38E-01	3,33E-02
6,68E-02	8,32E-03
1,32E-02	2,63E-03
3,21E-02	3,23E-04

Buck Switch Characteristics

figure 5.	IGBT

Safe operating area

I_C = f(V_{CE})



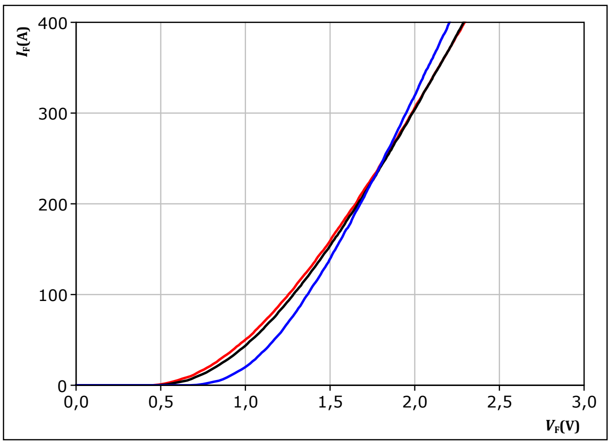
D =	single pulse	
T_s =	80	°C
V_{GE} =	15	V
T_j =	T_{jmax}	

Buck Diode Characteristics

figure 6. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



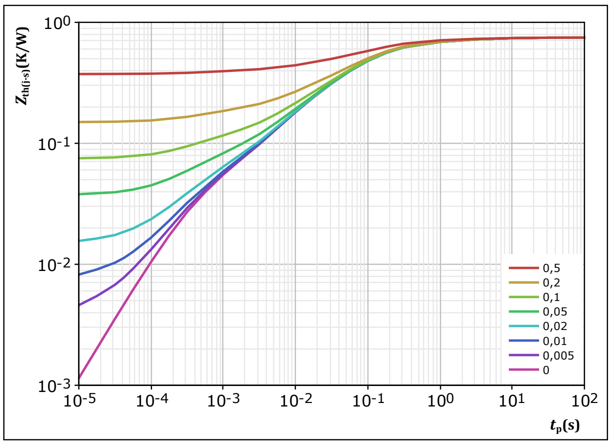
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 7. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



D = t_p / T

$R_{th(j-s)}$ = 0,748 K/W

FWD thermal model values

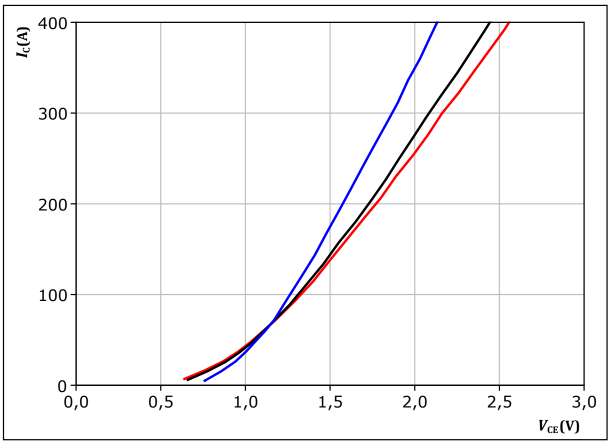
R (K/W)	τ (s)
2,88E-02	7,46E+00
7,02E-02	1,27E+00
1,95E-01	2,04E-01
2,65E-01	6,33E-02
1,21E-01	1,27E-02
3,39E-02	3,05E-03
3,36E-02	3,74E-04

Boost Switch Characteristics

figure 8. **IGBT**

Typical output characteristics

I_C = f(V_{CE})

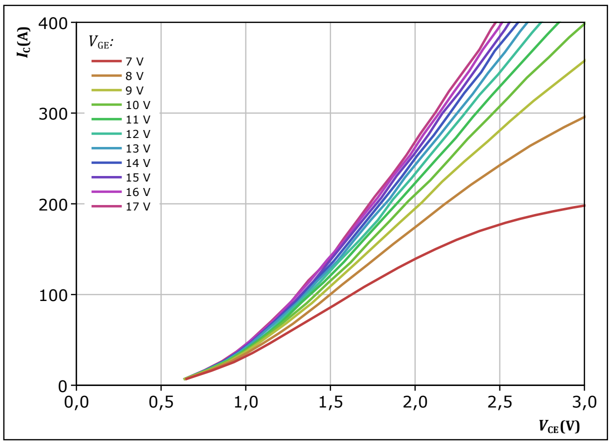


t_p =	250	µs		25 °C
V_{GE} =	15	V	T_j:	125 °C
				150 °C

figure 9. **IGBT**

Typical output characteristics

I_C = f(V_{CE})



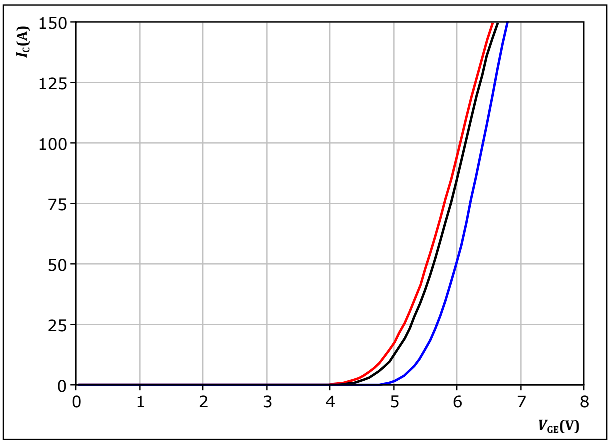
t_p =	250	µs
T_j =	150	°C

V_{GE} from 7 V to 17 V in steps of 1 V

figure 10. **IGBT**

Typical transfer characteristics

I_C = f(V_{GE})

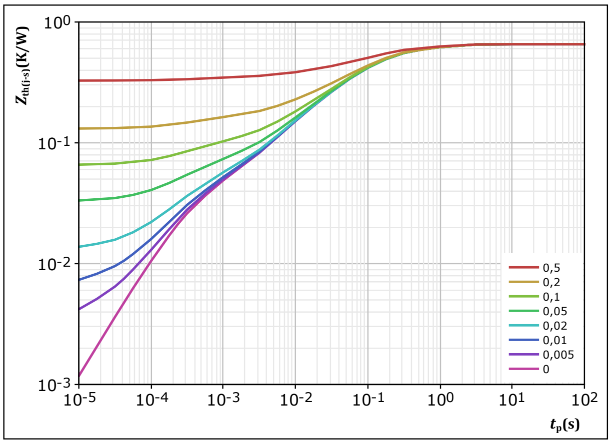


t_p =	250	µs		25 °C
V_{CE} =	10	V	T_j:	125 °C
				150 °C

figure 11. **IGBT**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)}$ = f(t_p)



D =	t_p / T	
$R_{th(j-s)}$ =	0,654	K/W

IGBT thermal model values

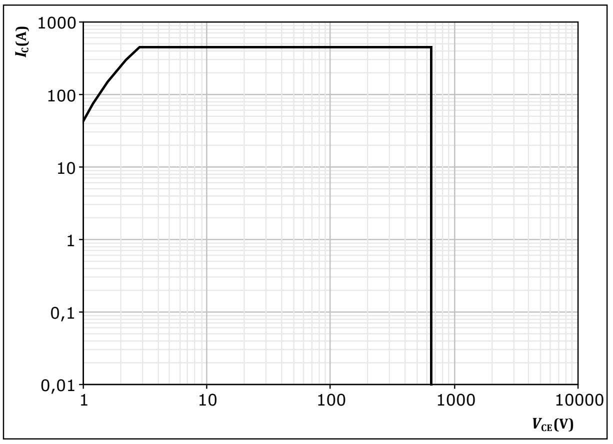
R (K/W)	τ (s)
1,13E-01	8,46E-01
2,91E-01	1,23E-01
1,38E-01	3,33E-02
6,68E-02	8,32E-03
1,32E-02	2,63E-03
3,21E-02	3,23E-04

Boost Switch Characteristics

figure 12.	IGBT

Safe operating area

$I_C = f(V_{CE})$



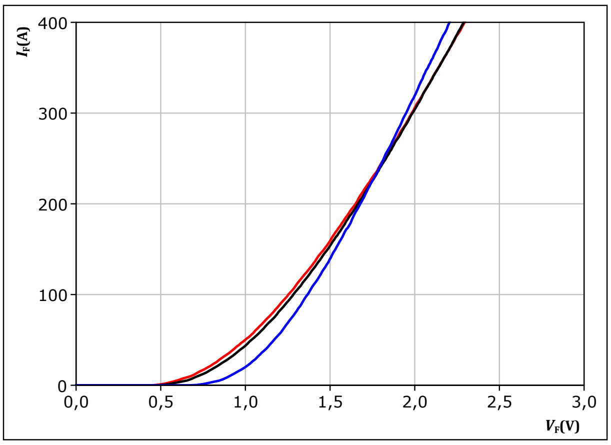
$D =$	single pulse	
$T_s =$	80	°C
$V_{GE} =$	15	V
$T_j =$	T_{jmax}	

Boost Diode Characteristics

figure 13. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



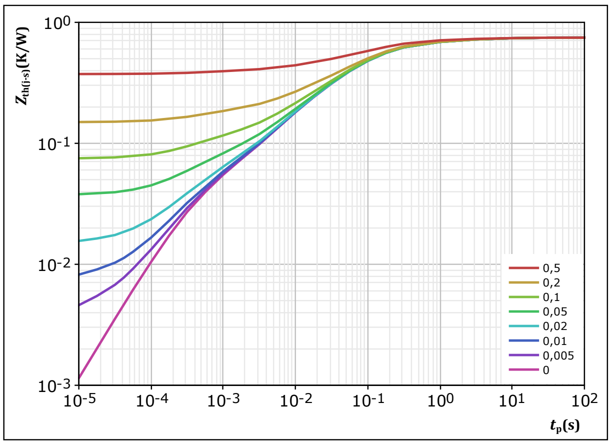
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 14. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 0,748 K/W

FWD thermal model values

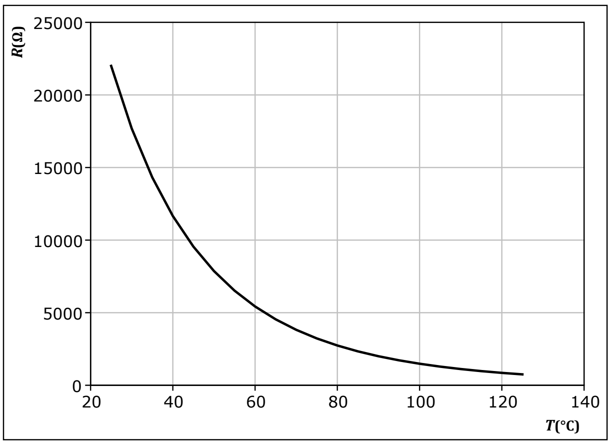
R (K/W)	τ (s)
2,88E-02	7,46E+00
7,02E-02	1,27E+00
1,95E-01	2,04E-01
2,65E-01	6,33E-02
1,21E-01	1,27E-02
3,39E-02	3,05E-03
3,36E-02	3,74E-04

Thermistor Characteristics

figure 15.	Thermistor

Typical NTC characteristic as function of temperature

R_T = f(T)

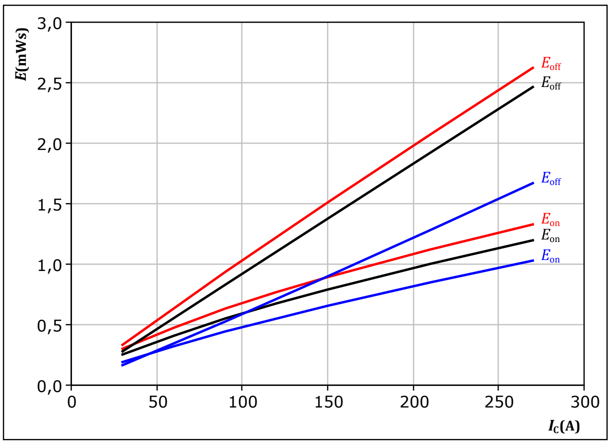


Buck Switching Characteristics

figure 16. **IGBT**

Typical switching energy losses as a function of collector current

$E = \mathrm{f}(I_C)$



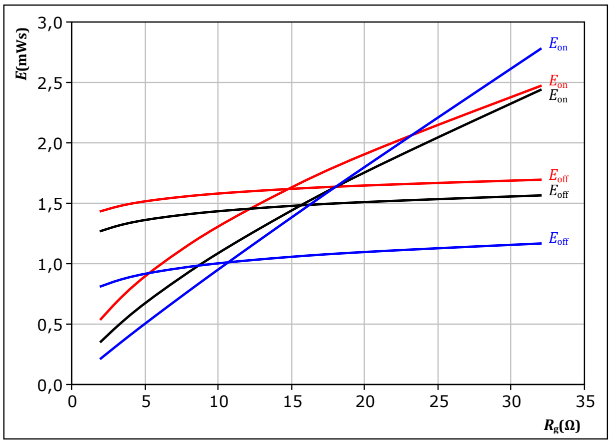
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C
R_{goff} =	8	Ω		

figure 17. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = \mathrm{f}(R_g)$



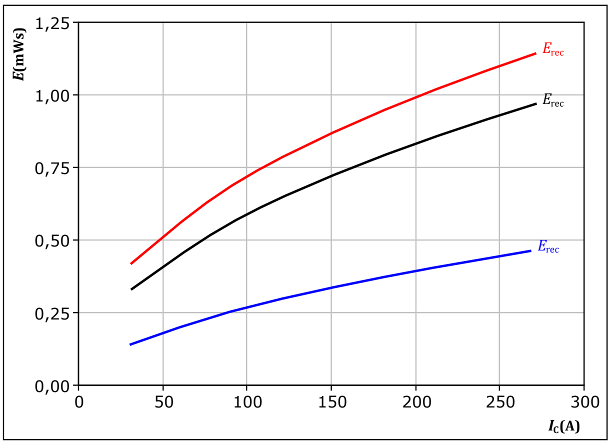
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

figure 18. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = \mathrm{f}(I_C)$



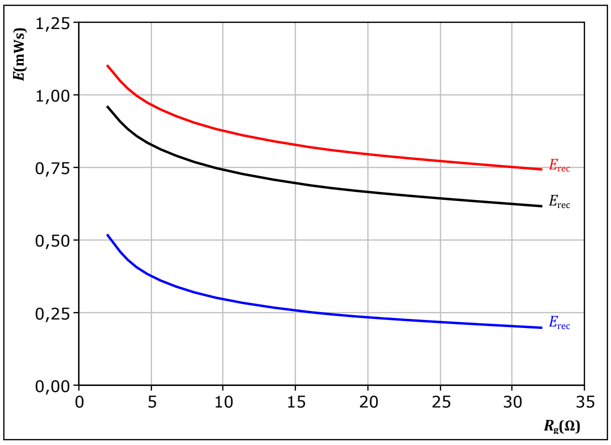
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 19. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = \mathrm{f}(R_g)$



With an inductive load at

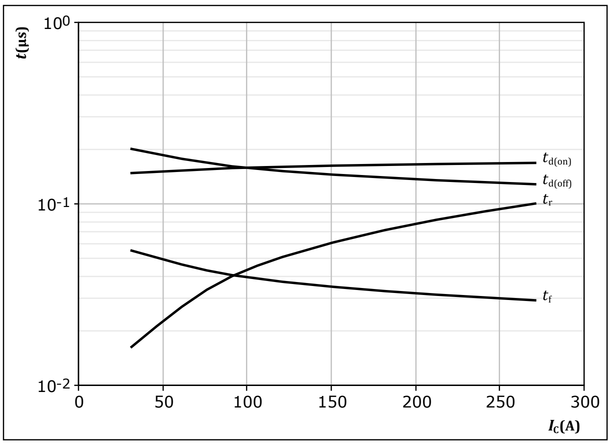
V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

Buck Switching Characteristics

figure 20. **IGBT**

Typical switching times as a function of collector current

t = f(I_C)



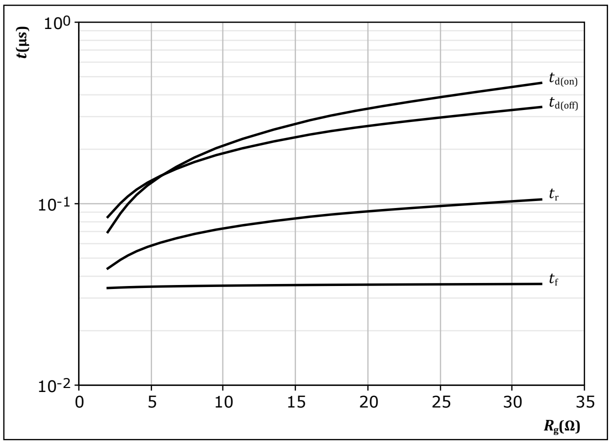
With an inductive load at

T_j =	150	°C
V_{CE} =	150	V
V_{GE} =	±15	V
R_{gon} =	8	Ω
R_{goff} =	8	Ω

figure 21. **IGBT**

Typical switching times as a function of gate resistor

t = f(R_g)



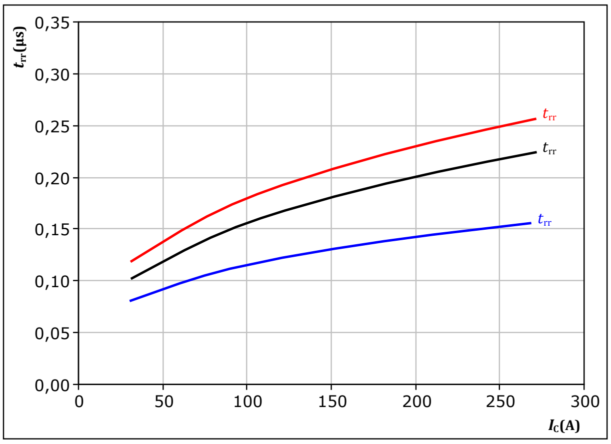
With an inductive load at

T_j =	150	°C
V_{CE} =	150	V
V_{GE} =	±15	V
I_C =	150	A

figure 22. **FWD**

Typical reverse recovery time as a function of collector current

t_{rr} = f(I_C)



With an inductive load at

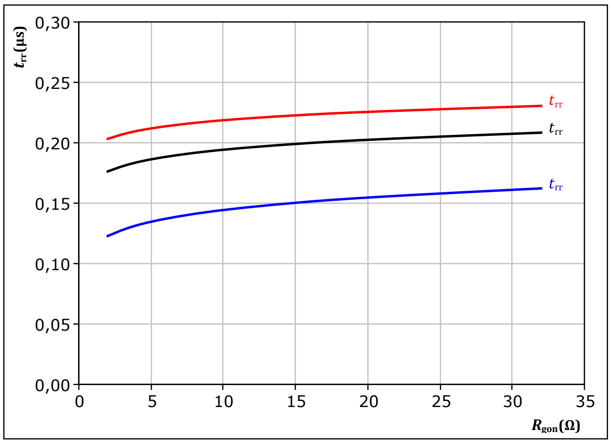
V_{CE} =	150	V
V_{GE} =	±15	V
R_{gon} =	8	Ω

T_j: 25 °C, 125 °C, 150 °C

figure 23. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

t_{rr} = f(R_{gon})



With an inductive load at

V_{CE} =	150	V
V_{GE} =	±15	V
I_C =	150	A

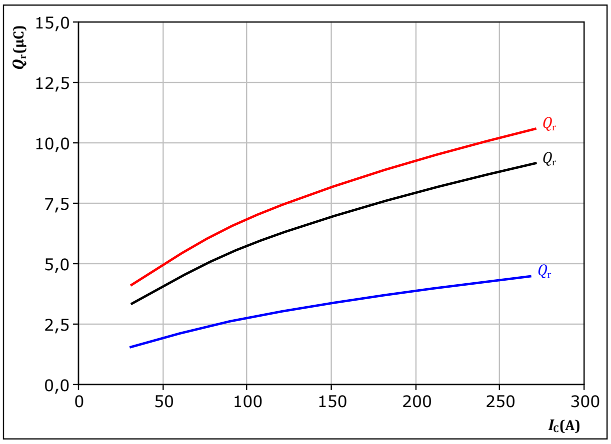
T_j: 25 °C, 125 °C, 150 °C

Buck Switching Characteristics

figure 24. **FWD**

Typical recovered charge as a function of collector current

Q_r = f(I_C)



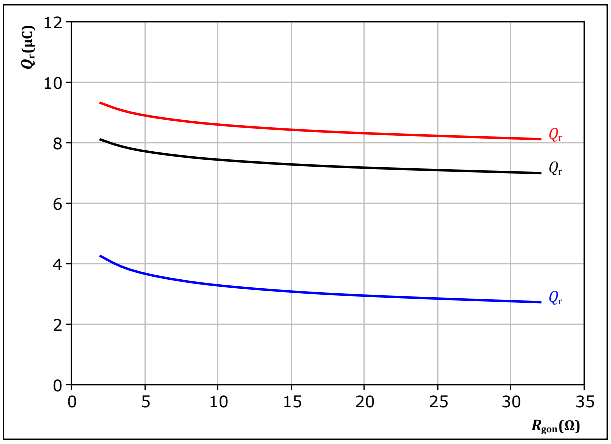
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 25. **FWD**

Typical recovered charge as a function of turn on gate resistor

Q_r = f(R_{gon})



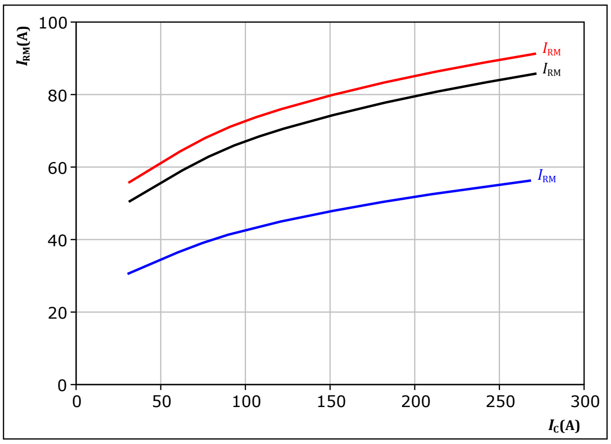
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

figure 26. **FWD**

Typical peak reverse recovery current as a function of collector current

I_{RM} = f(I_C)



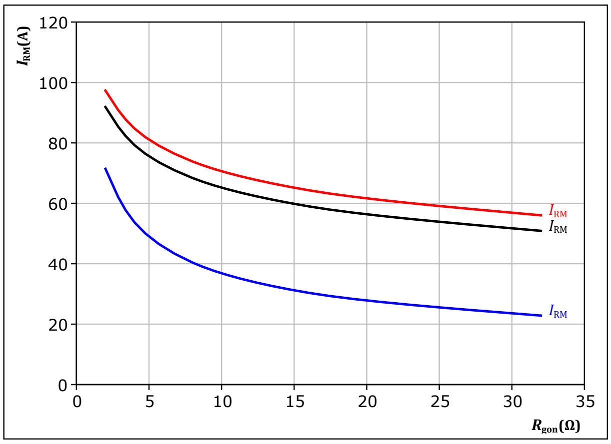
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 27. **FWD**

Typical peak reverse recovery current as a function of turn on gate resistor

I_{RM} = f(R_{gon})



With an inductive load at

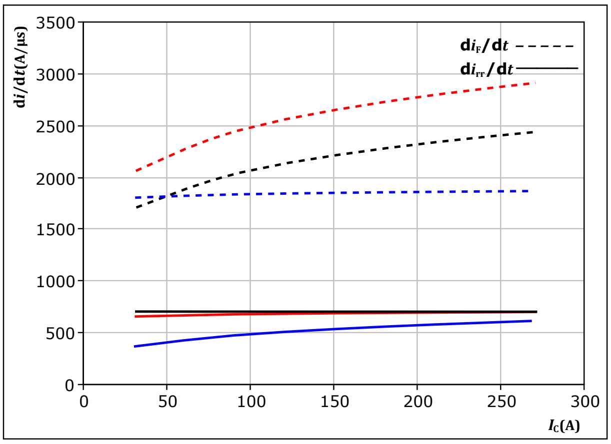
V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

Buck Switching Characteristics

figure 28. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, di_{rr}/dt = f(I_C)



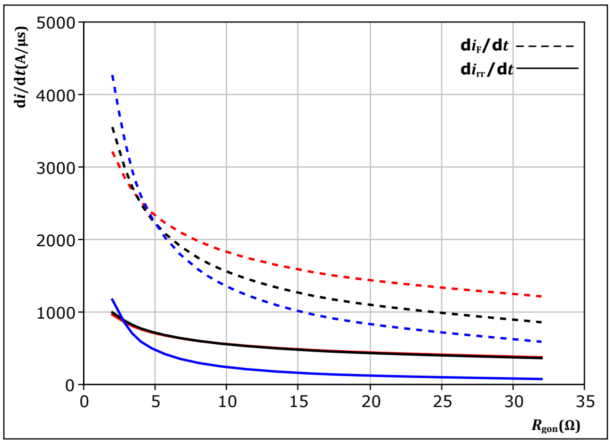
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 29. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor

di_F/dt, di_{rr}/dt = f(R_{gon})



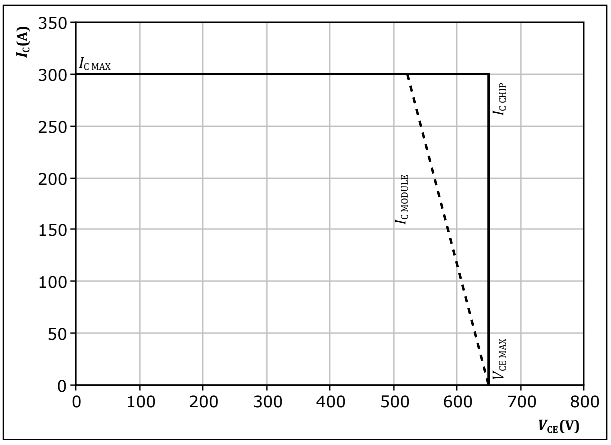
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

figure 30. **IGBT**

Reverse bias safe operating area

I_C = f(V_{CE})



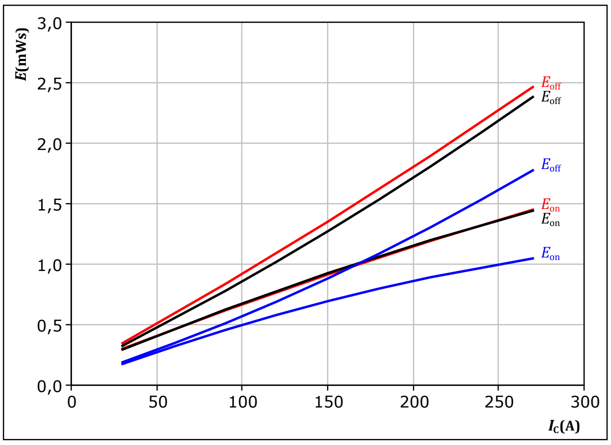
At	T_j =	150	°C
	R_{gon} =	8	Ω
	R_{goff} =	8	Ω

Boost Switching Characteristics

figure 31. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



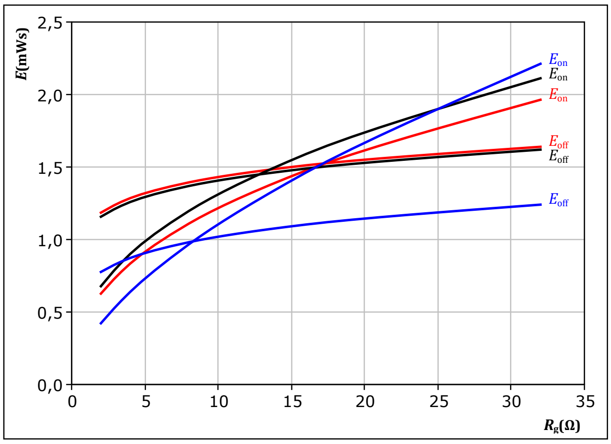
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C
R_{goff} =	8	Ω		

figure 32. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



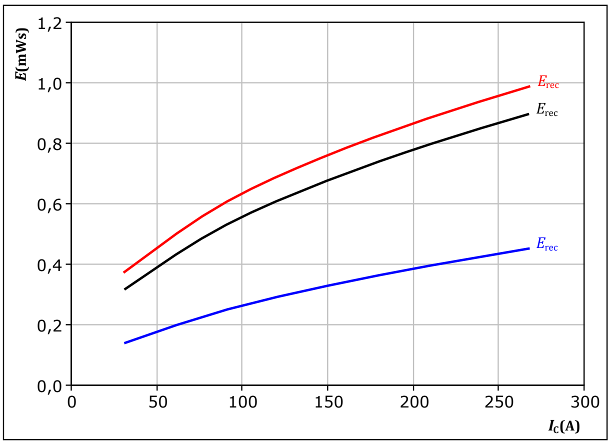
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

figure 33. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



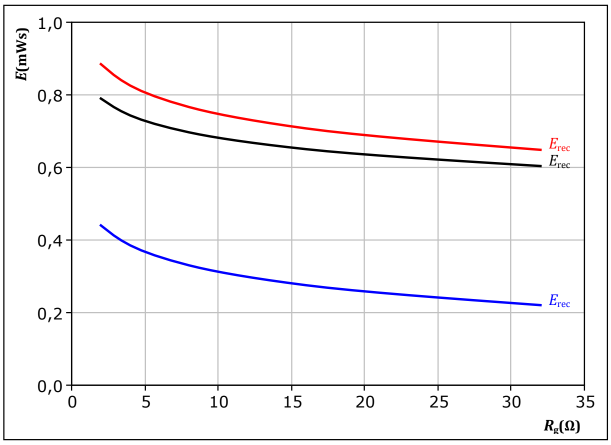
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 34. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

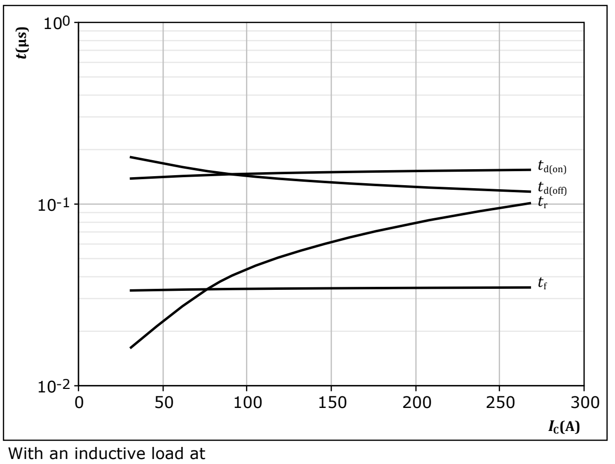
V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

Boost Switching Characteristics

figure 35. **IGBT**

Typical switching times as a function of collector current

t = f(I_C)



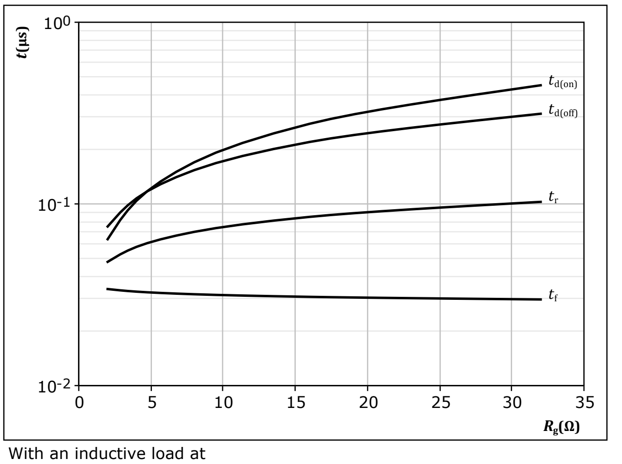
With an inductive load at

T_j =	150	°C
V_{CE} =	150	V
V_{GE} =	±15	V
R_{gon} =	8	Ω
R_{goff} =	8	Ω

figure 36. **IGBT**

Typical switching times as a function of gate resistor

t = f(R_g)



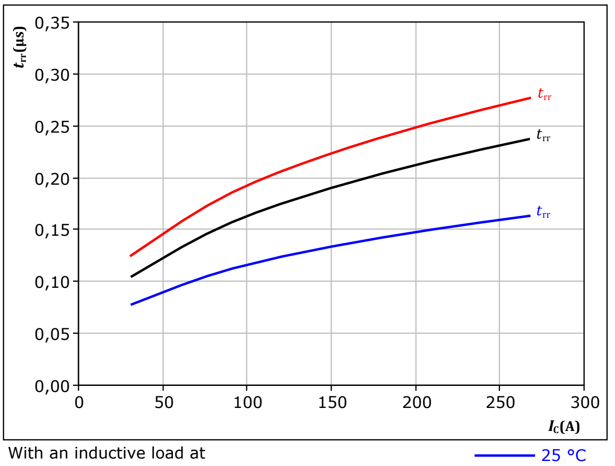
With an inductive load at

T_j =	150	°C
V_{CE} =	150	V
V_{GE} =	±15	V
I_C =	150	A

figure 37. **FWD**

Typical reverse recovery time as a function of collector current

t_{rr} = f(I_C)



With an inductive load at

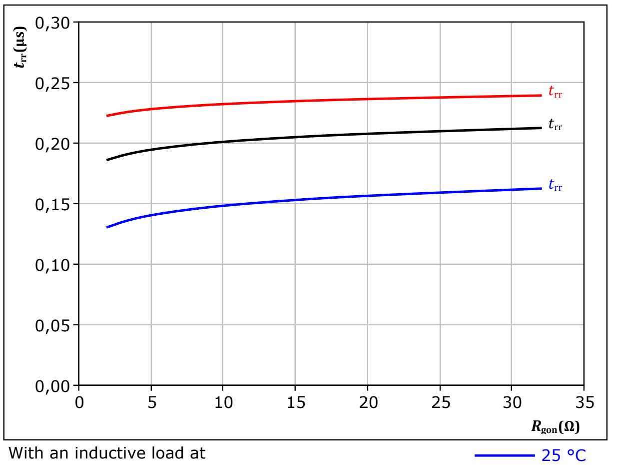
V_{CE} =	150	V
V_{GE} =	±15	V
R_{gon} =	8	Ω

T_j: 25 °C, 125 °C, 150 °C

figure 38. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

t_{rr} = f(R_{gon})



With an inductive load at

V_{CE} =	150	V
V_{GE} =	±15	V
I_C =	150	A

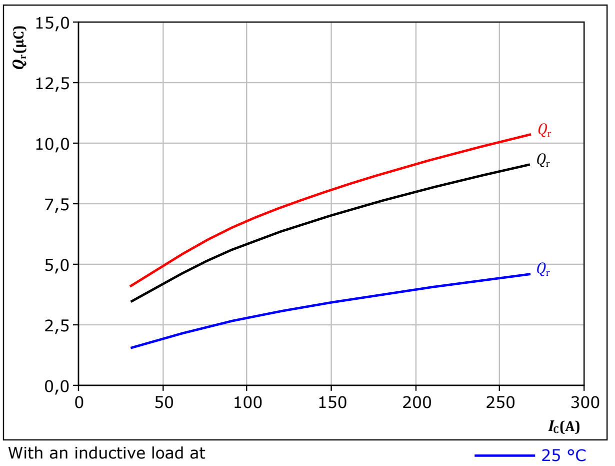
T_j: 25 °C, 125 °C, 150 °C

Boost Switching Characteristics

figure 39. **FWD**

Typical recovered charge as a function of collector current

Q_r = f(I_C)



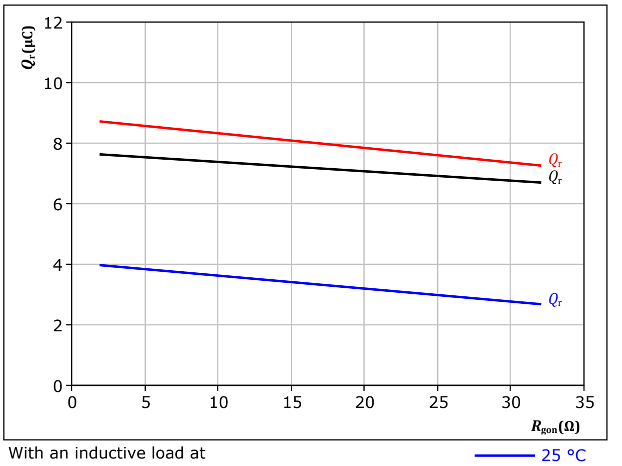
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 40. **FWD**

Typical recovered charge as a function of turn on gate resistor

Q_r = f(R_{gon})



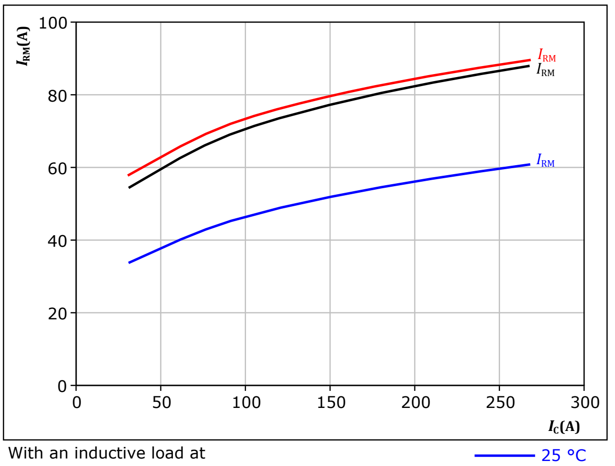
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

figure 41. **FWD**

Typical peak reverse recovery current as a function of collector current

I_{RM} = f(I_C)



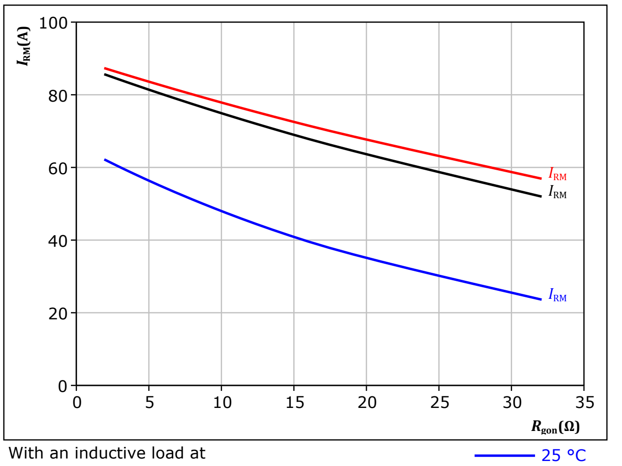
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 42. **FWD**

Typical peak reverse recovery current as a function of turn on gate resistor

I_{RM} = f(R_{gon})



With an inductive load at

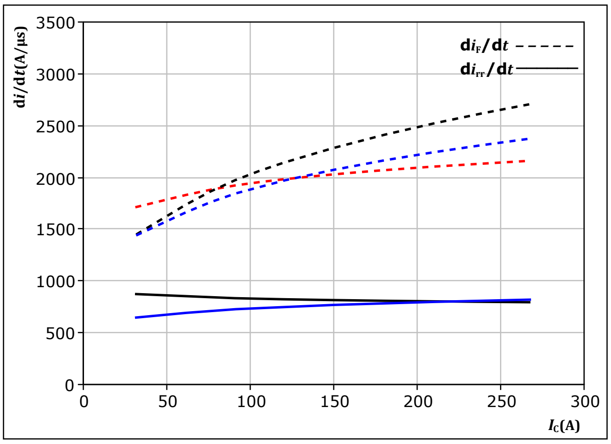
V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

Boost Switching Characteristics

figure 43. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, di_{rr}/dt = f(I_C)



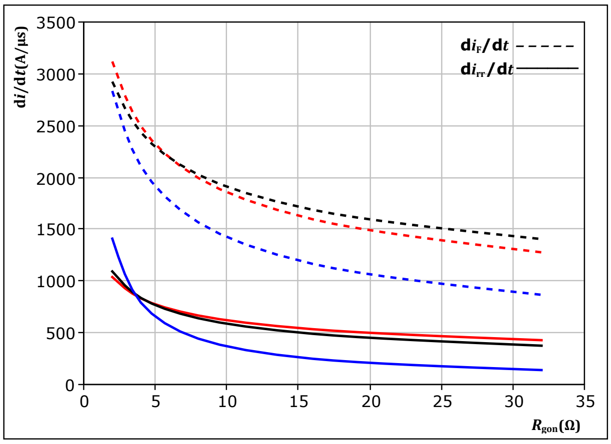
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 44. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor

di_F/dt, di_{rr}/dt = f(R_{gon})



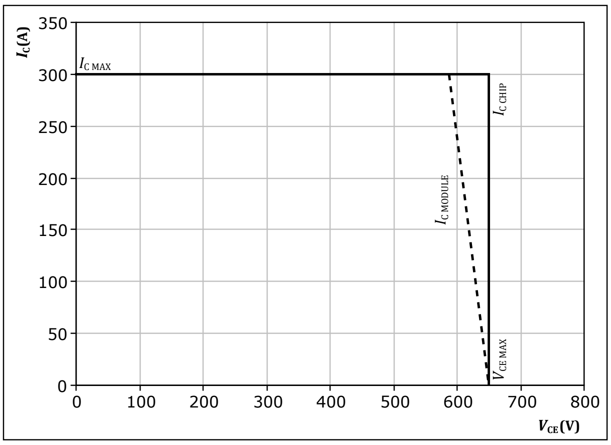
With an inductive load at

V_{CE} =	150	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	150	A		150 °C

figure 45. **IGBT**

Reverse bias safe operating area

I_C = f(V_{CE})



At	T_j =	150	°C
	R_{gon} =	8	Ω
	R_{goff} =	8	Ω

Switching Definitions

figure 46. **IGBT**

Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff} (t_{tEoff} = integrating time for E_{off})

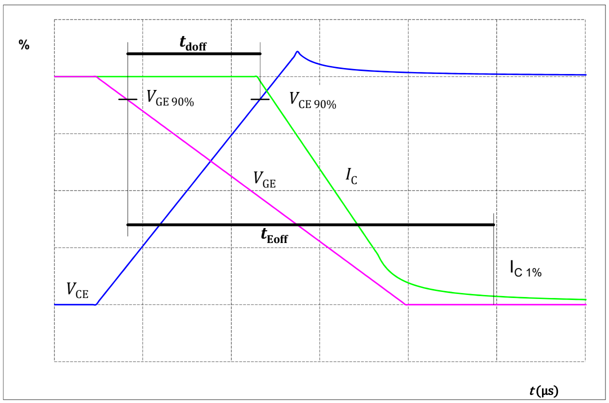


figure 47. **IGBT**

Turn-on Switching Waveforms & definition of t_{don}, t_{Eon} (t_{Eon} = integrating time for E_{on})

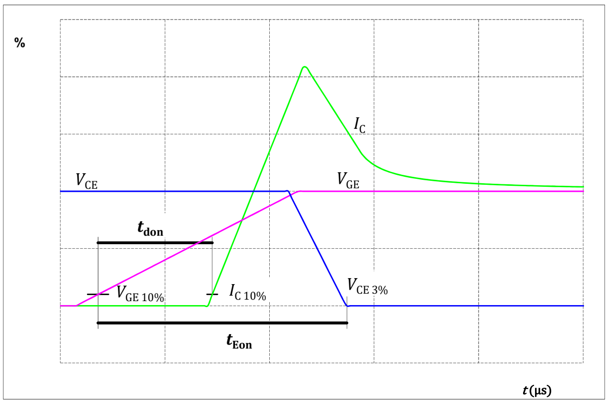


figure 48. **IGBT**

Turn-off Switching Waveforms & definition of t_f

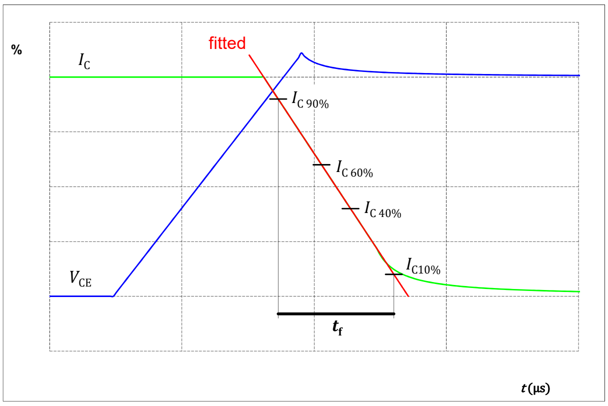
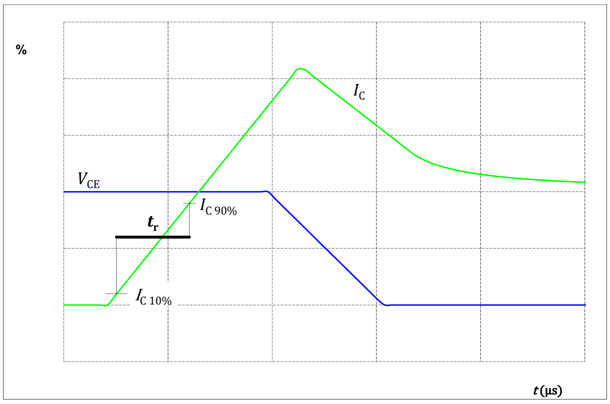


figure 49. **IGBT**

Turn-on Switching Waveforms & definition of t_r



Switching Definitions

figure 50. **FWD**

Turn-off Switching Waveforms & definition of t_{rr}

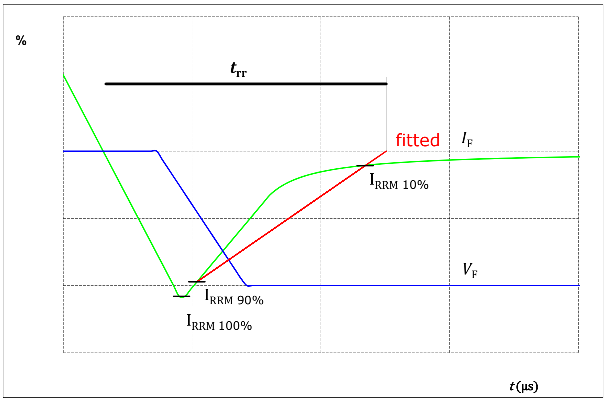
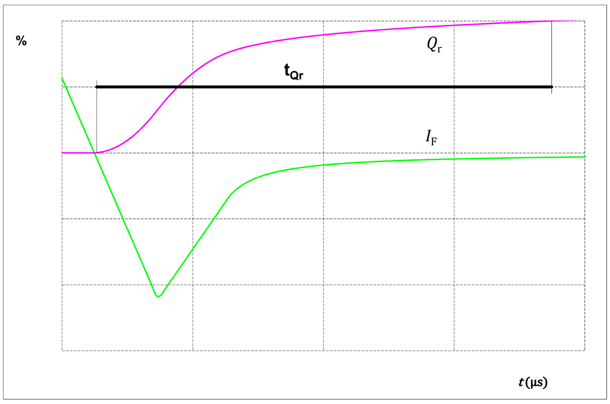


figure 51. **FWD**

Turn-on Switching Waveforms & definition of t_{Qr} **(** t_{Qr} **= integrating time for** Q_r**)**



Vincotech

Ordering Code

Version	Ordering Code
Without thermal paste	10-FY07NMB150S5-LE75F08
With thermal paste	10-FY07NMB150S5-LE75F08-/3/

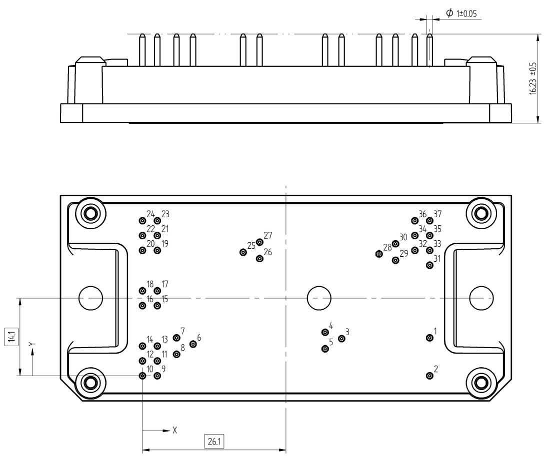
Marking

		Name		Date code	UL & VIN	Lot	Serial
	**Text**	NN-NNNNNNNNNNNNNN-TTTTTTTVV		WWYY	UL VIN	LLLLL	SSSS
	Datamatrix	**Type&Ver**	**Lot number**	**Serial**	**Date code**		
		TTTTTTTVV	LLLLL	SSSS	WWYY		

Outline

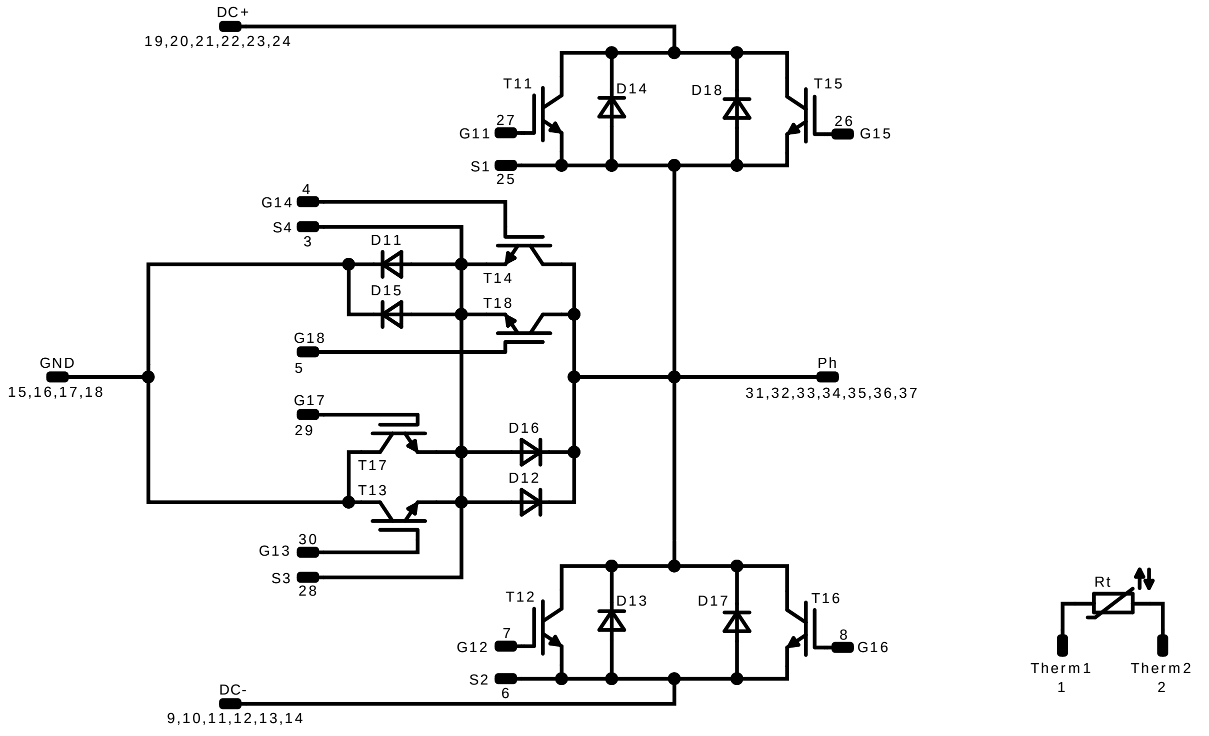
Pin	X	Y	Function
1	52,2	6,9	Therm1
2	52,2	0	Therm2
3	36,2	6,75	S4
4	33,2	7,9	G14
5	33,2	4,9	G18
6	9,2	5,75	S2
7	6,2	6,9	G12
8	6,2	3,9	G16
9	2,7	0	DC-
10	0	0	DC-
11	2,7	2,7	DC-
12	0	2,7	DC-
13	2,7	5,4	DC-
14	0	5,4	DC-
15	2,7	12,75	GND
16	0	12,75	GND
17	2,7	15,45	GND
18	0	15,45	GND
19	2,7	22,8	DC+
20	0	22,8	DC+
21	2,7	25,5	DC+
22	0	25,5	DC+
23	2,7	28,2	DC+
24	0	28,2	DC+
25	18,3	22,45	S1
26	21,3	21,3	G15
27	21,3	24,3	G11
28	43	22,15	S3
29	46	21	G17
30	46	24	G13
31	52,2	20,1	Ph
32	49,5	22,8	Ph
33	52,2	22,8	Ph
34	49,5	25,5	Ph
35	52,2	25,5	Ph
36	49,5	28,2	Ph
37	52,2	28,2	Ph

Pin table [mm]



Tolerance of pinpositions: ±0.5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance

Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T11, T15, T12, T16	IGBT	650 V	150 A	Buck Switch	Parallel devices with separate control. Values apply to complete device.
D11, D15, D12, D16	FWD	650 V	150 A	Buck Diode	Parallel devices. Values apply to complete device.
T13, T17, T14, T18	IGBT	650 V	150 A	Boost Switch	Parallel devices with separate control. Values apply to complete device.
D13, D17, D14, D18	FWD	650 V	150 A	Boost Diode	Parallel devices. Values apply to complete device.
Rt	Thermistor			Thermistor	

Packaging instruction				
Standard packaging quantity (SPQ) 100	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for *flow* 1 packages see vincotech.com website.

Package data
Package data for *flow* 1 packages see vincotech.com website.

Vincotech thermistor reference
See Vincotech thermistor reference table at vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website.

Document No.:	Date:	Modification:	Pages
10-FY07NMB150S5-LE75F08-D2-14	3 Mar. 2021	New Datasheet format, added PSX option Corrected minor documentation errors (module unchanged)	